



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	V _{(BR)DSS}	R _{DS(ON)} max	I_D max $T_A = +25$ °C
01	20	0.4Ω @ V _{GS} = 10V	0.65A
Q1	30	0.7Ω @ V _{GS} = 4.5V	0.52A
00	-30	0.9Ω @ V _{GS} = -10V	-0.45A
Q2		1.7Ω @ V _{GS} = -4.5V	-0.33A

Description and Applications

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Motor Control
- **Power Management Functions**
- **DC-DC Converters**

Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- **ESD Protected Gate**
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

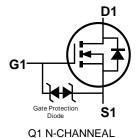
- Case: SOT363
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (§3)
- Weight: 0.027 grams (Approximate)

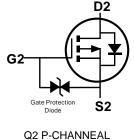


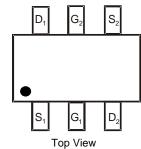


Top View









Pin out

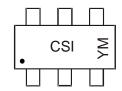
Ordering Information (Note 4)

Part Number	Case	Packaging
DMC3400SDW-7	SOT363	3000/Tape & Reel
DMC3400SDW-13	SOT363	10000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green"
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + CI) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



CSI = Product Type Marking Code YM = Date Code Marking Y or \overline{Y} = Year (ex: B = 2014) M = Month (ex: 9 = September)

Date Code Key

Year	201	4	2015		2016	20	17	2018		2019	2	2020
Code	В		С		D		Ε	F		G		Н
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value_Q1	Value_Q2	Units		
Drain-Source Voltage				30	-30	V
Gate-Source Voltage				±20	±20	V
Continuous Drain Current (Note 6) V _{GS} = 10V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	In.	0.65 0.50	-0.45 -0.36	Α
Maximum Continuous Body Diode Forward Currer	I _S	0.4	-0.35	Α		
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1	I _{DM}	4	-3	Α		

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 5)		P_{D}	0.31	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{\theta JA}$	406	°C/W
Total Power Dissipation (Note 6)		P_{D}	0.39	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{\theta JA}$	319	°C/W
Thermal Resistance, Junction to Case		R ₀ JC	126	°C/W
Operating and Storage Temperature Range		$T_{J,}T_{STG}$	-55 to +150	°C

Electrical Characteristics – N Channel – Q1 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)	1 -						
Drain-Source Breakdown Voltage	BV _{DSS}	30	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	-	-	1	μΑ	V _{DS} = 24V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	-	-	±10	μΑ	$V_{GS} = \pm 16V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)	<u>.</u>					·	
Gate Threshold Voltage	$V_{GS(TH)}$	0.8	-	1.6	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance		=	0.2	0.4	Ω	$V_{GS} = 10V, I_D = 0.59A$	
Static Diain-Source On-Resistance	R _{DS(ON)}	=	0.3	0.7	12	$V_{GS} = 4.5V, I_D = 0.2A$	
Diode Forward Voltage	V _{SD}	-	0.8	1.2	V	$V_{GS} = 0V, I_S = 0.23A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	-	55	-	pF		
Output Capacitance	Coss	=	8.5	-	pF	$V_{DS} = 15V, V_{GS} = 0V,$ - f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	-	6.5	-	pF	1 = 1.0IVII IZ	
Gate Resistance	Rg	-	92	-	Ω	$V_{DS} = V_{GS} = 0V$, $f = 1.0MHz$	
Total Gate Charge (V _{GS} = 4.5V)	Qg	-	0.6	-	nC		
Total Gate Charge (V _{GS} = 10V)	Qq	-	1.4	-	nC	V _{DS} = 10V,	
Gate-Source Charge	Q _{gs}	-	0.2	-	nC	I _D = 250mA	
Gate-Drain Charge	Q_{gd}	-	0.1	-	nC	7	
Turn-On Delay Time	t _{D(ON)}	-	3.8	-	ns		
Turn-On Rise Time	t _R	-	3.5	-	ns	$V_{GS} = 10V, V_{DS} = 30V,$	
Turn-Off Delay Time	t _{D(OFF)}	-	25.2	-	ns	$I_D = 100 \text{mA}, R_G = 1\Omega$	
Turn-Off Fall Time	t _F	-	18.8	-	ns	7	



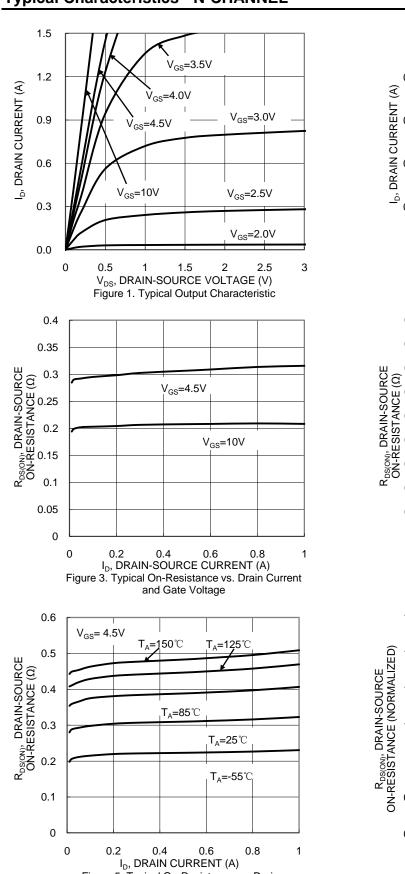
Electrical Characteristics – P Channel – Q2 (@T_A = +25°C, unless otherwise specified.)

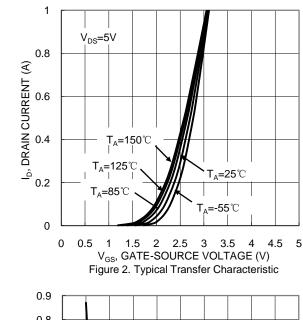
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	-30	-	-	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	-	-	-1	μΑ	$V_{DS} = -24V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	±10	μΑ	$V_{GS} = \pm 16V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V _{GS(TH)}	-1	-	-2.6	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$	
Static Drain-Source On-Resistance		-	0.36	0.9	Ω	$V_{GS} = -10V, I_D = -0.42A$	
Static Drain-Source On-Resistance	R _{DS(ON)}	-	0.57	1.7	Ω	$V_{GS} = -4.5V$, $I_{D} = -0.2A$	
Diode Forward Voltage	V _{SD}	-	-0.8	-1.2	V	$V_{GS} = 0V, I_{S} = -0.23A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	-	54	-	pF	151/11/	
Output Capacitance	Coss	-	10	-	рF	$V_{DS} = -15V, V_{GS} = 0V,$ - f = 1.0MHz	
Reverse Transfer Capacitance	Crss	-	8.3	-	pF	1 – 1.01/11/12	
Gate Resistance	Rg	-	240	-	Ω	$V_{DS} = V_{GS} = 0V$, $f = 1.0MHz$	
Total Gate Charge (V _{GS} = -4.5V)	Qg	-	0.6	-	nC		
Total Gate Charge (V _{GS} = -10V)	Qg	-	1.3	-	nC	V _{DS} = -10V. I _D = -0.24A	
Gate-Source Charge	Q _{gs}	-	0.2	-	nC	$V_{DS} = -10V, I_{D} = -0.24A$	
Gate-Drain Charge	Q _{gd}	-	0.2	-	nC	1	
Turn-On Delay Time	t _{D(ON)}	-	5.7	-	ns		
Turn-On Rise Time	t _R	-	8.8	-	ns	$V_{GS} = -10V, V_{DD} = -15V,$	
Turn-Off Delay Time	t _{D(OFF)}	-	35	-	ns	$I_D = -0.5A, R_G = 1\Omega$	
Turn-Off Fall Time	t _F	-	19	-	ns		

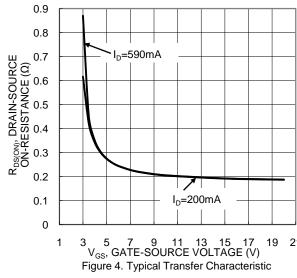
- 5. Device mounted on FR-4 PCB, with minimum recommended pad layout.
- Device mounted on 1" x 1" FR-4 PCB with high coverage 2oz. Copper, single sided.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.



Typical Characteristics - N-CHANNEL







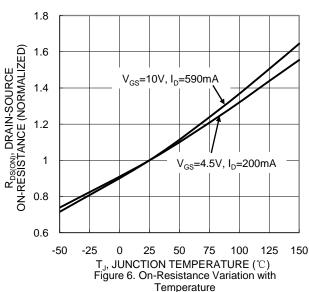
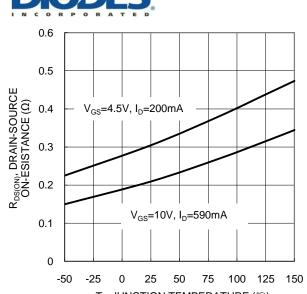


Figure 5. Typical On-Resistance vs. Drain Current and Temperature



 T_J , JUNCTION TEMPERATURE ($^{\circ}$ C) Figure 7. On-Resistance Variation with Temperature

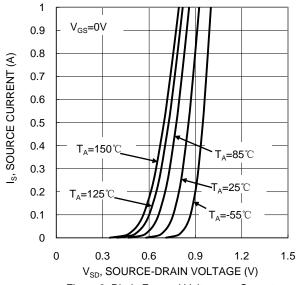
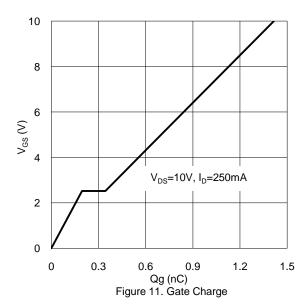


Figure 9. Diode Forward Voltage vs. Current



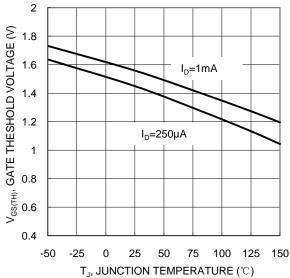


Figure 8. Gate Theshold Variation vs. Junction Temperature

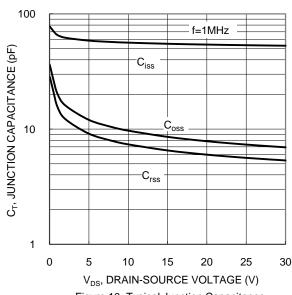
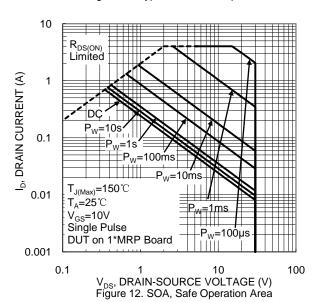
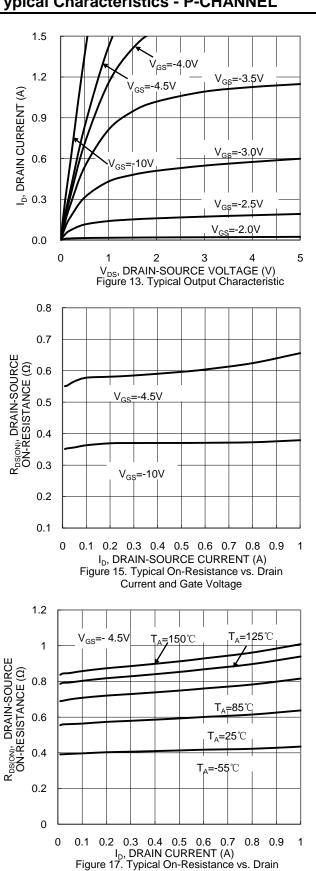


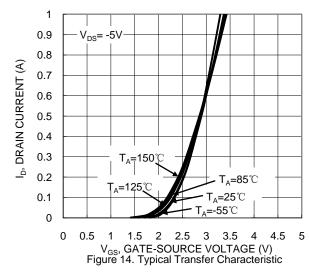
Figure 10. Typical Junction Capacitance

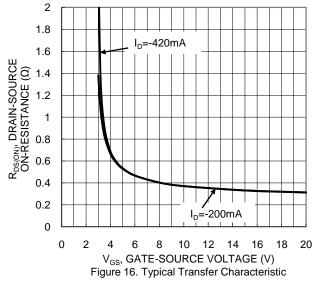


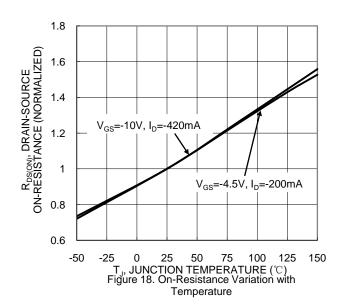


Typical Characteristics - P-CHANNEL



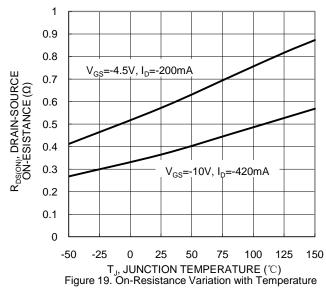


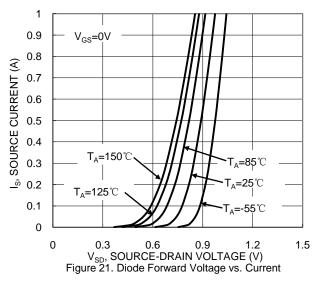


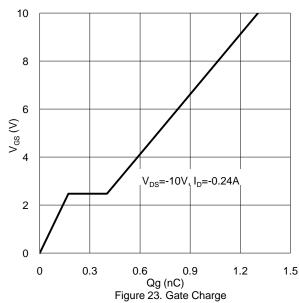


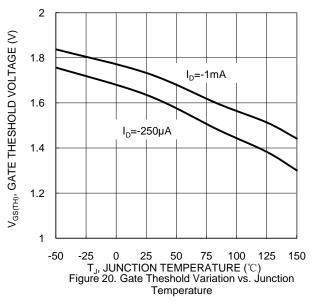
Current and Temperature

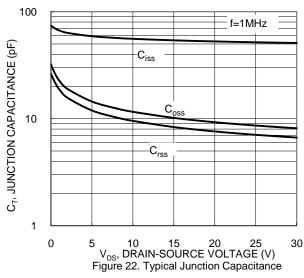


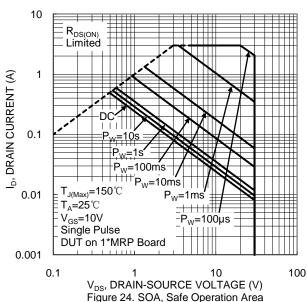




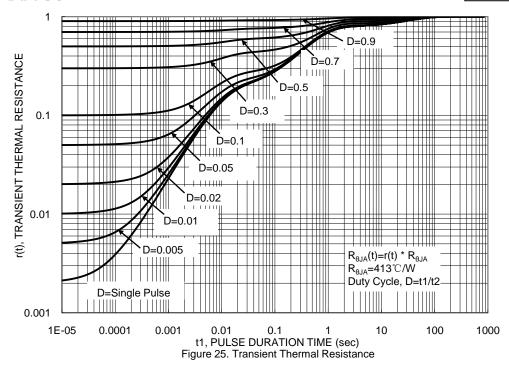






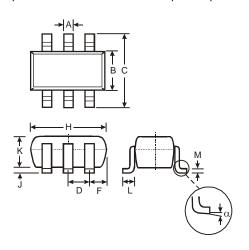






Package Outline Dimensions

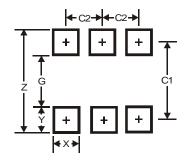
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf the for latest version.



	SOT363								
Dim	Min	Max	Тур						
A	0.10	0.30	0.25						
В	1.15	1.35	1.30						
U	2.00	2.20	2.10						
D	0.65 Typ								
F	0.40	0.45	0.425						
Н	1.80	2.20	2.15						
J	0	0.10	0.05						
K	0.90	1.00	1.00						
L	0.25	0.40	0.30						
M	0.10	0.22	0.11						
α	0°	8°	-						
All Dimensions in mm									

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf the for the latest version.



Dimensions	Value (in mm)
Z	2.5
G	1.3
Х	0.42
Υ	0.6
C1	1.9
C2	0.65



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